

AO3400A 30V N-Channel MOSFET

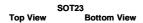
General Description

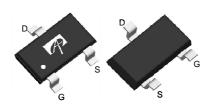
The AO3400A combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is suitable for use as a load switch or in PWM applications.

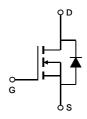
Product Summary

 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 5.7A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 26.5 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 32 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 2.5V) & < 48 m\Omega \end{array}$









Absolute Maximum Ratings T _A =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	30	V			
Gate-Source Voltage		V _{GS}	±12	V			
Continuous Drain	T _A =25℃	1	5.7				
Current	T _A =70℃	I _D	4.7	A			
Pulsed Drain Current ^C		I _{DM}	30				
	T _A =25℃	В	1.4	W			
Power Dissipation ^B	T _A =70℃	P _D	0.9	VV			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C			

Thermal Characteristics								
Parameter		Symbol Typ		Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	D	70	90	€/M			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	100	125	€/W			
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	63	80	€\M			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Parameter Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V		
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V				1	μА		
	ŭ	T _J =55°				5			
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V$, $V_{GS}=\pm 12V$				100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		0.65	1.05	1.45	V		
$I_{D(ON)}$	On state drain current	V_{GS} =4.5V, V_{DS} =5V		30			Α		
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =5.7A			18	26.5	mΩ		
			T _J =125℃		28	38			
		V_{GS} =4.5V, I_D =5A			19	32	mΩ		
		V_{GS} =2.5V, I_D =3A		24	48	$m\Omega$			
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =5.7A			33		S		
V_{SD}	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$			0.7	1	V		
Is	Maximum Body-Diode Continuous Current					2	Α		
DYNAMIC	PARAMETERS								
C_{iss}	Input Capacitance				630		pF		
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			75		pF		
C _{rss}	Reverse Transfer Capacitance				50		pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1.5	3	4.5	Ω		
SWITCHI	NG PARAMETERS								
Q_g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =15V, I _D =5.7A			6	7	nC		
Q_{gs}	Gate Source Charge				1.3		nC		
Q_{gd}	Gate Drain Charge				1.8		nC		
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =15V, R_L =2.6 Ω , R_{GEN} =3 Ω			3		ns		
t _r	Turn-On Rise Time				2.5		ns		
t _{D(off)}	Turn-Off DelayTime				25		ns		
t _f	Turn-Off Fall Time				4		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =5.7A, dI/dt=100A/μs			8.5		ns		
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =5.7A, dI/dt=100A/μs			2.6	-	nC		

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leqslant 10s junction-to-ambient thermal resistance.

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C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_{.1}=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

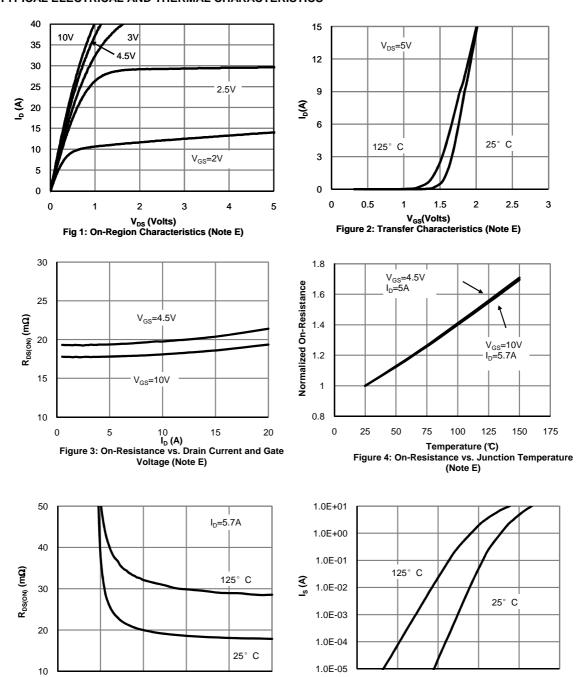
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(\text{MAX})}$ =150° C. The SOA curve provides a single pulse rating.



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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage

(Note E)

0.0

0.2

0.4

V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

0.6

8.0

1.0



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

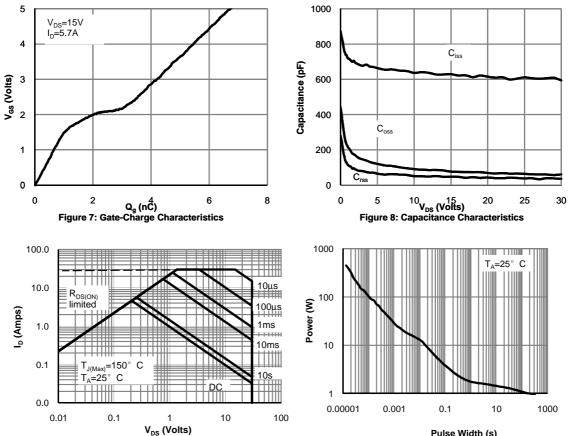


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toAmbient (Note F)

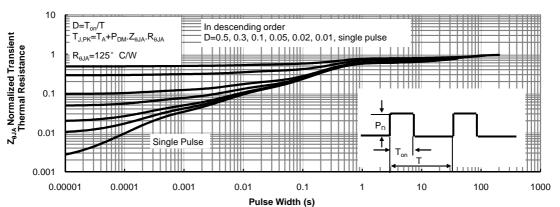
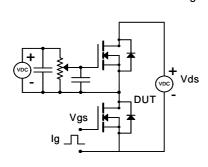
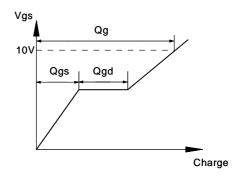


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

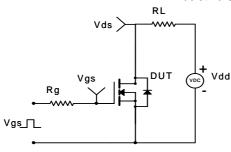


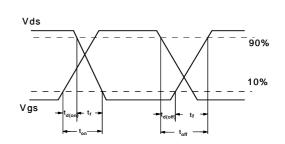
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

